

INFORMATION DISCLOSURE STATEMENT BY APPLICANT		ATTY. DOCKET NO. 067471-0074		SERIAL NO. 10/536,962		
		APPLICANT Yuuichi INABA, et al.				
		FILING DATE April 06, 2006		GROUP 2892		
(Substitute for form 1449/PTO)						
U.S. PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ₂ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		US				
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FOREIGN PATENT DOCUMENTS						
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
		JP 06-061462	03-04-1994	MATSUSHITA ELECTRONICS CORP		JAPAN (w/English abstract)
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
		"Basics of Solid State Imaging Device", December 1999, Pages 183-188, Nihon Riko Shuppankai, with partial English translation and Verification of partial English translation				
EXAMINER		DATE CONSIDERED				

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.
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